

April 1988 Revised August 1999

74F574

Octal D-Type Flip-Flop with 3-STATE Outputs

General Description

The 74F574 is a high-speed, low power octal flip-flop with a buffered common Clock (CP) and a buffered common Output Enable $\overline{(\text{OE})}$. The information presented to the D inputs is stored in the flip-flops on the LOW-to-HIGH Clock (CP) transition.

This device is functionally identical to the 74F374 except for the pinouts.

Features

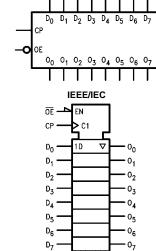
- Inputs and outputs on opposite sides of package allowing easy interface with microprocessors
- Useful as input or output port for microprocessors
- Functionally identical to 74F374
- 3-STATE outputs for bus-oriented applications

Ordering Code:

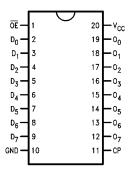
Order Number	Package Number	Package Description
74F574SC	M20B	20-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide
74F574SJ	M20D	20-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
74F574PC	N20A	20-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Logic Symbols



Connection Diagram



Unit Loading/Fan Out

Pin Names	Description	U.L.	Input I _{IH} /I _{IL}	
Pin Names	Description	HIGH/LOW	Output I _{OH} /I _{OL}	
D ₀ –D ₇	Data Inputs	1.0/1.0	20 μA/–0.6 mA	
CP	Clock Pulse Input (Active LOW)	1.0/1.0	20 μA/–0.6 mA	
ŌE	3-STATE Output Enable Input (Active LOW)	1.0/1.0	20 μA/–0.6 mA	
O ₀ -O ₇	3-STATE Outputs	150/40 (33.3)	-3 mA/24 mA (20 mA)	

Functional Description

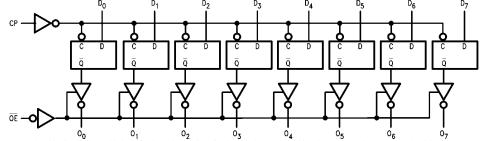
The 74F574 consists of eight edge-triggered flip-flops with individual D-type inputs and 3-STATE true outputs. The buffered clock and buffered Output Enable are common to all flip-flops. The eight flip-flops will store the state of their individual D inputs that meet the setup and hold times requirements on the LOW-to-HIGH Clock (CP) transition. With the Output Enable (OE) LOW, the contents of the eight flip-flops are available at the outputs. When $\overline{\text{OE}}$ is HIGH, the outputs go to the high impedance state. Operation of the \overline{OE} input does not affect the state of the flip-

Function Table

ı	nputs	i	Internal	Outputs	Function		
OE	СР	D	Q	0	Function		
Н	Н	L	NC	Z	Hold		
Н	Н	Н	NC	Z	Hold		
Н	_	L	L	Z	Load		
Н	~	Н	Н	Z	Load		
L	_	L	L	L	Data Available		
L	~	Н	Н	Н	Data Available		
L	Н	L	NC	NC	No Change in Data		
L	Н	Н	NC	NC	No Change in Data		

- H = HIGH Voltage Level
 L = LOW Voltage Level
 X = Immaterial
 Z = High Impedance
 _ = LOW-to-HIGH Transition
 NC = No Change

Logic Diagram



Absolute Maximum Ratings(Note 1)

Input Current (Note 2)
Voltage Applied to Output

in HIGH State (with V_{CC} = 0V)

 $-30\ \text{mA}$ to $+5.0\ \text{mA}$

Current Applied to Output

in LOW State (Max) twice the rated I_{OL} (mA)

Recommended Operating Conditions

Free Air Ambient Temperature $0^{\circ}\text{C} \text{ to } +70^{\circ}\text{C}$ Supply Voltage +4.5V to +5.5V

Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation

under these conditions is not implied.

Note 2: Either voltage limit or current limit is sufficient to protect inputs.

DC Electrical Characteristics

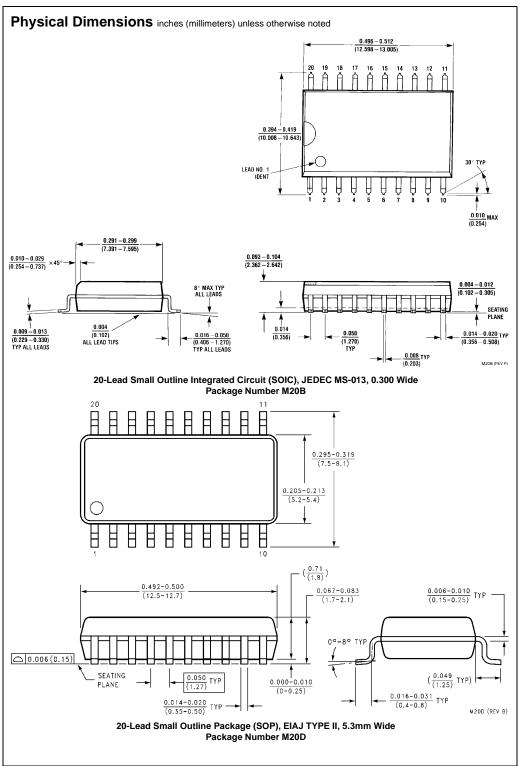
Symbol	Parameter		Min	Тур	Max	Units	v _{cc}	Conditions
V _{IH}	Input HIGH Voltage		2.0			V		Recognized as a HIGH Signal
V _{IL}	Input LOW Voltage				0.8	V		Recognized as a LOW Signal
V _{CD}	Input Clamp Diode Voltage				-1.2	V	Min	I _{IN} = -18 mA
V _{OH}	Output HIGH	10% V _{CC}	2.5					I _{OH} = -1 mA
	Voltage	10% V _{CC}	2.4			V	Min	$I_{OH} = -3 \text{ mA}$
		5% V _{CC}	2.7			V	IVIIN	$I_{OH} = -1 \text{ mA}$
		5% V _{CC}	2.7					$I_{OH} = -3 \text{ mA}$
V _{OL}	Output LOW	400/ \/			0.5	V	Min	1 04 4
	Voltage	10% V _{CC}			0.5	V	IVIII	I _{OL} = 24 mA
I _{IH}	Input HIGH				5.0	^	Max	V _{IN} = 2.7V
	Current				5.0	μА	IVIAX	$v_{IN} = 2.7 v$
I _{BVI}	Input HIGH Current				7.0	^	Max	1/ 701/
	Breakdown Test				7.0	μА	IVIAX	V _{IN} = 7.0V
I _{CEX}	Output HIGH				50	μА	Max	V - V
	Leakage Current				50	μΑ	IVIAX	$V_{OUT} = V_{CC}$
V _{ID}	Input Leakage		4.75			V	0.0	I _{ID} = 1.9 μA
	Test		4.75			V	0.0	All Other Pins Grounded
I _{OD}	Output Leakage				3.75	μА	0.0	V _{IOD} = 150 mV
	Circuit Current				3.73	μΑ	0.0	All Other Pins Grounded
I _{IL}	Input LOW Current				-0.6	mA	Max	V _{IN} = 0.5V
I _{OZH}	Output Leakage Current				50	μΑ	Max	V _{OUT} = 2.7V
I _{OZL}	Output Leakage Current				-50	μΑ	Max	V _{OUT} = 0.5V
Ios	Output Short-Circuit Current		-60		-150	mA	Max	V _{OUT} = 0V
I _{ZZ}	Bus Drainage Test				500	μΑ	0.0V	V _{OUT} = 5.25V
I _{CCZ}	Power Supply Current			55	86	mA	Max	V _O = HIGH Z

AC Electrical Characteristics

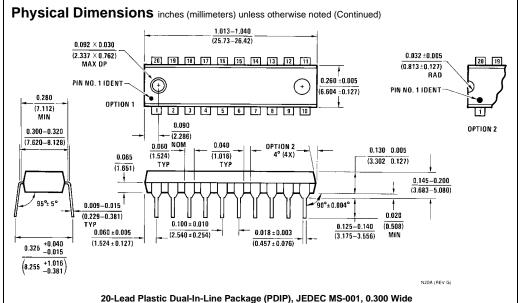
Symbol	Parameter		$T_A = +25^{\circ}C$ $V_{CC} = +5.0V$ $C_1 = 50 \text{ pF}$			$T_A = -55^{\circ}C \text{ to } +125^{\circ}C$ $V_{CC} = +5.0V$ $C_L = 50 \text{ pF}$		$T_A = 0^{\circ}C \text{ to } +70^{\circ}C$ $V_{CC} = +5.0V$ $C_1 = 50 \text{ pF}$	
		Min	Typ	Max	Min	Max	Min	Max	
f _{MAX}	Maximum Clock Frequency	100			60		70		MHz
t _{PLH}	Propagation Delay	2.5	5.3	8.5	2.5	9.5	2.5	8.5	
t _{PHL}	CP to O _n	2.5	5.3	8.5	2.5	9.5	2.5	8.5	ns
t _{PZH}	Output Enable Time	3.0	5.5	9.0	2.5	10.5	2.5	10.0	
t _{PZL}		3.0	6.0	9.0	2.5	10.5	2.5	10.0	
t _{PHZ}	Output Disable Time	1.5	3.3	5.5	1.5	7.0	1.5	6.5	ns
t _{PLZ}		1.5	2.8	5.5	1.5	7.0	1.5	6.5	

AC Operating Requirements

Combal	Davameter	$T_A = +25^{\circ}C$ $V_{CC} = +5.0V$		$T_A = -55^{\circ}C \text{ to } +125^{\circ}C$ $V_{CC} = +5.0V$		$T_A = 0$ °C to +70°C $V_{CC} = +5.0V$		Units
Symbol	Parameter							
		Min	Max	Min	Max	Min	Max	
t _S (H)	Set-up Time, HIGH or LOW	2.5		3.0		2.5		
t _S (L)	D _n to CP	2.0		2.5		2.0		ns
t _H (H)	Hold Time, HIGH or LOW	2.0		2.0		2.0		115
t _H (L)	D _n to CP	2.0		2.0		2.0		
t _W (H)	CP Pulse Width	5.0		5.0		5.0		ns
t _W (L)	HIGH or LOW	5.0		5.0		5.0		113



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Package Number N20A

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